

<b>Notice of References Cited</b>	Application/Control No. 10/646,996	Applicant(s)/Patent Under Reexamination FUJII ET AL.	
	Examiner Chau N Nguyen	Art Unit 2831	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,670,555	12-2003	Ota et al.	174/135
	B	US-4,371,230	02-1983	Inoue, Nori	439/849
	C	US-4,832,620	05-1989	Yamamoto, Nobumasa	439/422
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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